

# **6th SRF Materials Workshop**

## **Report of Contributions**

Contribution ID: 0

Type: **not specified**

## **Heat treatment and passivation of SRF Nb cavities**

*Thursday, 18 February 2010 09:10 (10 minutes)*

**Presenter:** , Ciovati (JLab)

**Session Classification:** Session 1: Recent cavity results and drivers

Contribution ID: 1

Type: **not specified**

## **Materials issues from FNAL/ANL 1.3 GHz processing experience and consideration of Project X at 650 MHz**

*Thursday, 18 February 2010 08:40 (20 minutes)*

**Presenter:** , Cooley (FNAL)

**Session Classification:** Session 1: Recent cavity results and drivers

Contribution ID: 2

Type: **not specified**

## **Can we predict performance of 650 MHz cavities?**

*Thursday, 18 February 2010 09:00 (10 minutes)*

**Presenter:** , Sergatskov (FNAL)

**Session Classification:** Session 1: Recent cavity results and drivers

Contribution ID: 3

Type: **not specified**

## Locating Quenches With Second Sound

*Thursday, 18 February 2010 09:40 (10 minutes)*

**Presenter:** , Liepe (Cornell)

**Session Classification:** Session 1: Recent cavity results and drivers

Contribution ID: 4

Type: **not specified**

## Discussion

*Thursday, 18 February 2010 09:50 (20 minutes)*

**Session Classification:** Session 1: Recent cavity results and drivers

Contribution ID: 5

Type: **not specified**

## **Search for pit formation mechanisms – weld coupon electropolishing**

*Thursday, 18 February 2010 10:30 (10 minutes)*

**Presenter:** , Cooley (FNAL)

**Session Classification:** Session 2: Recent coupon results and drivers

Contribution ID: 6

Type: **not specified**

## **Recent developments in understanding the mild baking effect**

*Thursday, 18 February 2010 10:40 (20 minutes)*

**Presenter:** , Romanenko (FNAL)

**Session Classification:** Session 2: Recent coupon results and drivers



Contribution ID: 27

Type: **not specified**

## **Light vs. heavy electropolishing**

*Friday, 19 February 2010 08:35 (10 minutes)*

**Presenter:** , Reece (JLab)

**Session Classification:** Session 5: Final processing, coating, repair

Contribution ID: 46

Type: **not specified**

## Opening remarks and workshop guidelines

*Thursday, 18 February 2010 08:30 (10 minutes)*

**Presenter:** , Cooley (FNAL)

Contribution ID: 47

Type: **not specified**

## **Laser heating investigation of SRF cavities**

*Thursday, 18 February 2010 09:20 (10 minutes)*

**Presenter:** , Ciovati (JLab)

**Session Classification:** Session 1: Recent cavity results and drivers

Contribution ID: 48

Type: **not specified**

## Migration of quench location

*Thursday, 18 February 2010 09:30 (10 minutes)*

**Presenter:** , Sergatskov (FNAL)

**Session Classification:** Session 1: Recent cavity results and drivers

Contribution ID: 49

Type: **not specified**

## **Effect of Low T baking on field emission and Nb surface oxide layer structure**

*Thursday, 18 February 2010 11:00 (10 minutes)*

**Presenter:** , Wu (JLab)

**Session Classification:** Session 2: Recent coupon results and drivers

Contribution ID: 50

Type: **not specified**

## **Annealing Temperature and Thermal Conductivity of Superconducting Niobium**

*Thursday, 18 February 2010 11:10 (10 minutes)*

**Presenter:** , Wright (MSU)

**Session Classification:** Session 2: Recent coupon results and drivers

Contribution ID: 51

Type: **not specified**

## **Further evidence for localized magnetic moments in the surface oxides of air-exposed niobium**

*Thursday, 18 February 2010 11:20 (10 minutes)*

**Presenter:** , Zasadzinski (IIT)

**Session Classification:** Session 2: Recent coupon results and drivers

Contribution ID: 52

Type: **not specified**

## **Evidence for suppressed superconductivity across buffer chemically polished grain boundaries of SRF quality niobium**

*Thursday, 18 February 2010 11:40 (20 minutes)*

**Presenter:** , Sung (FSU)

**Session Classification:** Session 2: Recent coupon results and drivers



Contribution ID: 53

Type: **not specified**

## Discussion

*Thursday, 18 February 2010 12:00 (20 minutes)*

**Session Classification:** Session 2: Recent coupon results and drivers

Contribution ID: 54

Type: **not specified**

## Effects of materials defects on the physics of SRF

*Thursday, 18 February 2010 13:40 (20 minutes)*

**Presenter:** , Gurevich (FSU)

**Session Classification:** Session 3: Ideal limits to SRF

Contribution ID: 55

Type: **not specified**

## **Superheating field of niobium**

*Thursday, 18 February 2010 14:00 (20 minutes)*

**Presenter:** , Liepe (Cornell)

**Session Classification:** Session 3: Ideal limits to SRF

Contribution ID: 56

Type: **not specified**

## **Vortex dissipation as an origin of Q-slope and quench**

*Thursday, 18 February 2010 14:20 (20 minutes)*

**Presenter:** , Dzyuba (FNAL)

**Session Classification:** Session 3: Ideal limits to SRF

Contribution ID: 57

Type: **not specified**

## Discussion

*Thursday, 18 February 2010 14:40 (20 minutes)*

**Session Classification:** Session 3: Ideal limits to SRF

Contribution ID: 58

Type: **not specified**

## **Basic mechanisms of electropolishing**

*Thursday, 18 February 2010 15:00 (20 minutes)*

**Presenter:** , Reece (for Tian, JLab)

**Session Classification:** Session 4: Surface processing — bulk removal

Contribution ID: 59

Type: **not specified**

## **Development of computational algorithms to predict surface morphology and evolution during electropolishing**

*Thursday, 18 February 2010 15:20 (10 minutes)*

**Presenter:** , Brankovic (Houston)

**Session Classification:** Session 4: Surface processing — bulk removal

Contribution ID: **60**

Type: **not specified**

## **Integrated Cavity Processing at JLab**

*Thursday, 18 February 2010 15:50 (10 minutes)*

**Presenter:** , Reece (JLab)

**Session Classification:** Session 4: Surface processing — bulk removal (cont.)



Contribution ID: **61**

Type: **not specified**

## **FNAL Integrated Cavity Processing Apparatus for single-cell R&D**

*Thursday, 18 February 2010 16:10 (10 minutes)*

**Presenter:** , Cooper (FNAL)

**Session Classification:** Session 4: Surface processing — bulk removal (cont.)

Contribution ID: **62**

Type: **not specified**

## **Industrialization of vertical electropolishing**

*Thursday, 18 February 2010 16:20 (20 minutes)*

**Presenter:** , Conway (Cornell)

**Session Classification:** Session 4: Surface processing — bulk removal (cont.)

Contribution ID: **63**

Type: **not specified**

## **VEP at JLab**

*Thursday, 18 February 2010 16:40 (10 minutes)*

**Presenter:** , Reece (JLab)

**Session Classification:** Session 4: Surface processing — bulk removal (cont.)

Contribution ID: 64

Type: **not specified**

## **The need for tumbling and recent tumbling results at FNAL**

*Thursday, 18 February 2010 16:50 (10 minutes)*

**Presenter:** , Cooper (FNAL)

**Session Classification:** Session 4: Surface processing — bulk removal (cont.)

Contribution ID: 65

Type: **not specified**

## **Fluoride-free electropolishing of niobium cavities for next-generation particle accelerators**

*Thursday, 18 February 2010 17:00 (10 minutes)*

**Presenter:** , Zhao (Va. Tech)

**Session Classification:** Session 4: Surface processing — bulk removal (cont.)

Contribution ID: 66

Type: **not specified**

## **Processing Effects and Use of Electrochemical Abrasive Jet Polishing for Nb-SRF Cavities**

*Thursday, 18 February 2010 17:10 (10 minutes)*

**Presenter:** , Muftu (Northeastern)

**Session Classification:** Session 4: Surface processing — bulk removal (cont.)

Contribution ID: 67

Type: **not specified**

## Discussion

*Thursday, 18 February 2010 17:30 (20 minutes)*

**Session Classification:** Session 4: Surface processing — bulk removal (cont.)

Contribution ID: **68**

Type: **not specified**

## Opening remarks

*Friday, 19 February 2010 08:30 (5 minutes)*

**Presenter:** , Cooley (FNAL)



Contribution ID: 69

Type: **not specified**

## **Restoration of maximum gradient by laser re-melting a cavity pit**

*Friday, 19 February 2010 08:45 (20 minutes)*

**Presenter:** , Ge (FNAL)

**Session Classification:** Session 5: Final processing, coating, repair

Contribution ID: 70

Type: **not specified**

## **Capabilities and design philosophy of a dual resolution inspection and repair system for SRF cavities**

*Friday, 19 February 2010 09:05 (10 minutes)*

**Presenter:** , Bearden (MicroDynamics)

**Session Classification:** Session 5: Final processing, coating, repair

Contribution ID: 71

Type: **not specified**

## **Surface Treatment of Niobium SRF Cavity by Plasma Etching**

*Friday, 19 February 2010 09:15 (10 minutes)*

**Presenter:** , Upadhyay (ODU)

**Session Classification:** Session 5: Final processing, coating, repair

Contribution ID: 72

Type: **not specified**

## **Progress in niobium coatings by PE-ALD**

*Friday, 19 February 2010 09:25 (10 minutes)*

**Presenter:** , Prolier (ANL)

**Session Classification:** Session 5: Final processing, coating, repair

Contribution ID: 73

Type: **not specified**

## Discussion

*Friday, 19 February 2010 09:35 (15 minutes)*

**Session Classification:** Session 5: Final processing, coating, repair

Contribution ID: 74

Type: **not specified**

## TE Cavity work

*Friday, 19 February 2010 10:10 (10 minutes)*

**Presenter:** , Liepe (Cornell)

**Session Classification:** Session 6: Q(E) and Rs measurements

Contribution ID: 75

Type: **not specified**

## **Current Status of Dielectric Test Cavity and Wafer Test Cavity**

*Friday, 19 February 2010 10:20 (10 minutes)*

**Presenter:** , Pogue (TAMU)

**Session Classification:** Session 6:  $Q(E)$  and  $R_s$  measurements

Contribution ID: 76

Type: **not specified**

## **RF Critical Magnetic Field Measurements of Nb/(Insulator)/MgB<sub>2</sub> Systems**

*Friday, 19 February 2010 10:30 (10 minutes)*

**Presenter:** , Tajima (LANL)

**Session Classification:** Session 6: Q(E) and R<sub>s</sub> measurements



Contribution ID: 77

Type: **not specified**

## **Local measurements of the electron mean free path**

*Friday, 19 February 2010 10:40 (10 minutes)*

**Presenter:** , Phillips (JLab)

**Session Classification:** Session 6: Q(E) and Rs measurements

Contribution ID: 78

Type: **not specified**

## **Progress in near-field microwave microscopy of superconducting materials**

*Friday, 19 February 2010 10:50 (10 minutes)*

**Presenter:** , Anlage (Maryland)

**Session Classification:** Session 6:  $Q(E)$  and  $R_s$  measurements

Contribution ID: 79

Type: **not specified**

## Discussion

*Friday, 19 February 2010 11:00 (20 minutes)*

**Session Classification:** Session 6: Q(E) and Rs measurements

Contribution ID: 80

Type: **not specified**

## **Plans for improving stockpile and cost of fine-grained niobium and chipless forming of ingot niobium into cavity subassemblies**

*Friday, 19 February 2010 11:20 (10 minutes)*

**Presenter:** , Grimm (Niowave)

**Session Classification:** Session 7: Forming and Welding

Contribution ID: **81**

Type: **not specified**

## **Direct and indirect process feedbacks for the fabrication of 1.3 GHz elliptical SRF resonators to improve production yields**

*Friday, 19 February 2010 11:30 (10 minutes)*

**Presenter:** , Edinger (Pavac)

**Session Classification:** Session 7: Forming and Welding

Contribution ID: **82**

Type: **not specified**

## **Dislocations in niobium**

*Friday, 19 February 2010 11:40 (20 minutes)*

**Presenter:** , Baars (MSU)

**Session Classification:** Session 7: Forming and Welding

Contribution ID: **83**

Type: **not specified**

## **Homogenization of Nb microstructures**

*Friday, 19 February 2010 12:00 (10 minutes)*

**Presenter:** , Balachandran (TAMU)

**Session Classification:** Session 7: Forming and Welding

Contribution ID: **84**

Type: **not specified**

## **Cryotesting of niobium polycrystals**

*Friday, 19 February 2010 13:30 (10 minutes)*

**Presenter:** , Bieler (MSU)

**Session Classification:** Session 7: Forming and Welding (cont.)



Contribution ID: 85

Type: **not specified**

## **Fabrication of ILC cavities from axisymmetric RRR Nb tubes**

*Friday, 19 February 2010 13:40 (10 minutes)*

**Presenter:** , Crooks (Black Laboratories)

**Session Classification:** Session 7: Forming and Welding (cont.)

Contribution ID: **86**

Type: **not specified**

## **Discussion**

*Friday, 19 February 2010 13:50 (10 minutes)*

**Session Classification:** Session 7: Forming and Welding (cont.)

Contribution ID: 87

Type: **not specified**

## **Update on MgB<sub>2</sub> deposition for SRF cavities**

*Friday, 19 February 2010 14:00 (10 minutes)*

**Presenter:** , Xi (Temple)

**Session Classification:** Session 8: Alternate Processes

Contribution ID: **88**

Type: **not specified**

## **Coupon and cavity studies of SRF thin films produced by energetic condensation**

*Friday, 19 February 2010 14:10 (10 minutes)*

**Presenter:** , Krishnan (Alameda Appl. Sci.)

**Session Classification:** Session 8: Alternate Processes

Contribution ID: **89**

Type: **not specified**

## **Discussion**

*Friday, 19 February 2010 14:20 (10 minutes)*

**Session Classification:** Session 8: Alternate Processes

Contribution ID: **90**

Type: **not specified**

## Opening remarks

*Saturday, 20 February 2010 08:30 (10 minutes)*

**Presenter:** , Cooley (FNAL)

Contribution ID: **91**

Type: **not specified**

## **Session 1 Summary**

*Saturday, 20 February 2010 08:40 (20 minutes)*

What are the primary materials R&D drivers from cavities and programs?

Contribution ID: 92

Type: **not specified**

## Session 2 Summary

*Saturday, 20 February 2010 09:00 (20 minutes)*

What are small-scale experiments telling us about how to proceed (or not proceed)?



Contribution ID: 93

Type: **not specified**

## Session 3 Summary

*Saturday, 20 February 2010 09:20 (20 minutes)*

What is the ideal surface? What ideas or models are most useful and immediately applicable?

Contribution ID: 94

Type: **not specified**

## Session 4 Summary

*Saturday, 20 February 2010 09:40 (20 minutes)*

Can we obtain the target surface reliably and reproducibly? What is optimum, and what needs improvement?

Contribution ID: 95

Type: **not specified**

## Session 5 Summary

*Saturday, 20 February 2010 10:10 (20 minutes)*

What are the important differences in the final surface structures in relation to the observed properties? What changes need to be made, and what new things should be tried?

Contribution ID: **96**

Type: **not specified**

## **Session 6 Summary**

*Saturday, 20 February 2010 10:30 (20 minutes)*

What techniques are useful and immediately applicable? Can property measurements bridge between coupons and cavities?

Contribution ID: 97

Type: **not specified**

## Session 7 Summary

*Saturday, 20 February 2010 10:50 (20 minutes)*

Do forming and welding produce downstream difficulties? What needs to be changes?

Contribution ID: **98**

Type: **not specified**

## **Session 8 Summary**

*Saturday, 20 February 2010 11:10 (20 minutes)*

Can coating technologies provide a meaningful impact and in a reasonable time frame?

Contribution ID: **99**

Type: **not specified**

## **Final discussion**

*Saturday, 20 February 2010 11:30 (30 minutes)*

Contribution ID: **100**

Type: **not specified**

## **Fundamental Surface Chemistry Studies of Niobium Oxidation**

*Thursday, 18 February 2010 11:30 (10 minutes)*

**Presenter:** , Nakajima (UChicago)

**Session Classification:** Session 2: Recent coupon results and drivers



Contribution ID: **101**

Type: **not specified**

## **Faradayic electropolishing**

*Thursday, 18 February 2010 17:20 (10 minutes)*

**Presenter:** , Inman (Faraday Technology)

**Session Classification:** Session 4: Surface processing — bulk removal (cont.)

Contribution ID: **102**

Type: **not specified**

## **EP temperature control strategies**

*Thursday, 18 February 2010 16:00 (10 minutes)*

**Presenter:** , Reece (JLab)

**Session Classification:** Session 4: Surface processing — bulk removal (cont.)